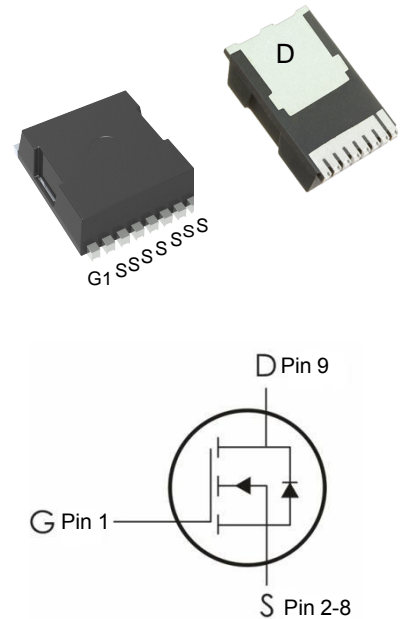


Description:

This N-Channel MOSFET uses advanced SGT technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=60V, I_D=350A, R_{DS(ON)} < 1.3m\Omega @ V_{GS}=10V$ (Typ: $1m\Omega$)
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density SGT technology for ultra low $R_{DS(ON)}$.
- 5) Excellent package for good heat dissipation.
- 6) MSL3



Package Marking and Ordering Information:

Part NO.	Marking	Package	Packing
LE1R3TFG	E1R3TF	TOLLA-8	2000 pcs/Reel

Absolute Maximum Ratings: ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current ¹	350	A
	Continuous Drain Current- $T_C=100^\circ C$ ¹	245	
I_{DM}	Pulsed Drain Current ²	1050	
P_D	Power Dissipation	290	W
E_{AS}	Single pulse avalanche energy ³	756	mJ
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55-+150	$^\circ C$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.43	$^\circ C/W$

Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu\text{A}$	60	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=60V$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics						
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu\text{A}$	2	3	4	V
$R_{DS(on)}$	Drain-Source On Resistance ⁴	$V_{GS}=10V, I_D=20A$	---	1	1.3	$\text{m}\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=30V, V_{GS}=0V, f=100\text{KHz}$	---	6500	---	pF
C_{oss}	Output Capacitance		---	2639	--	
C_{rss}	Reverse Transfer Capacitance		---	69	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=30V, I_D=30A,$ $R_{ENG}=3\ \Omega, V_{GS}=10V$	---	36.7	---	ns
t_r	Rise Time		---	76.6	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	79.8	---	ns
t_f	Fall Time		---	82	---	ns
Q_g	Total Gate Charge	$V_{GS}=10V, V_{DS}=30V,$ $I_D=30A$	---	130	---	nC
Q_{gs}	Gate-Source Charge		---	45	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	17.8	---	nC
Drain-Source Diode Characteristics						
V_{SD}	Diode Forward Voltage	$V_{GS}=0V, I_{SD}=30A$	---	---	1.2	V
I_S	Continuous Drain Current	$V_D=V_G=0V$	---	---	291.6	A
I_{SM}	Pulsed Drain Current		---	---	875	A
T_{rr}	Reverse Recovery Time	$I_F=30A, T_J=25^\circ\text{C}$	---	90	---	ns
Q_{rr}	Reverse Recovery Charge	$di/dt=100A/\mu\text{s}$	---	125	---	nC

Notes:

1. oмпuted continuous current assumes the condition of $T_{j,Max}$ while the actual continuous current depends on the thermal & electro-mechanical application board design
2. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
3. EAS condition : $T_J=25^{\circ}C, V_{DD}=30V, V_G=10V, L=0.5mH$
4. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$

Test Circuit

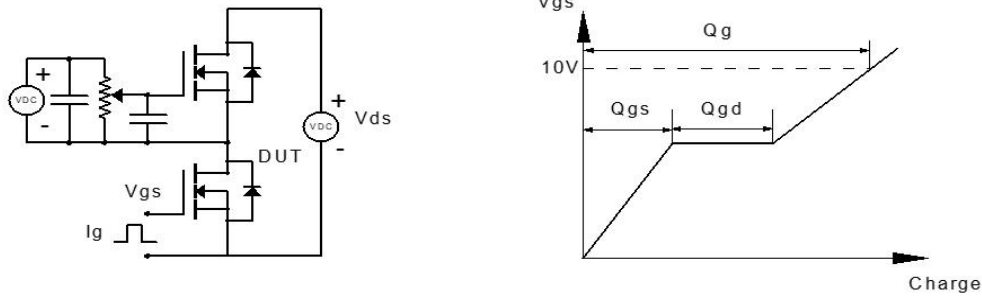


Figure 1: Gate Charge Test Circuit & Waveform

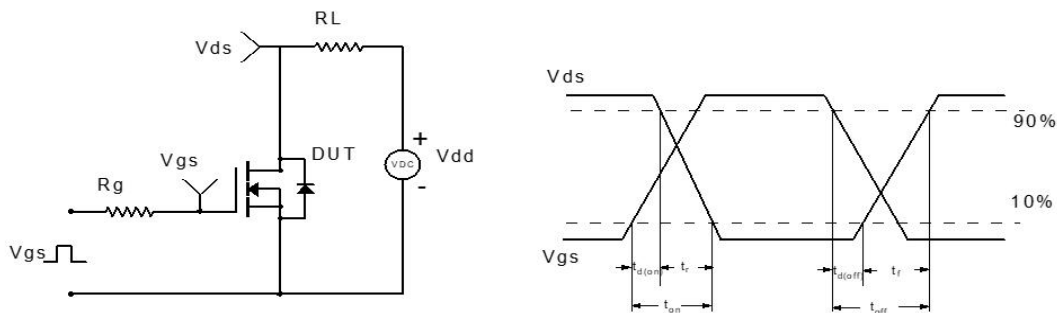


Figure 2: Resistive Switching Test Circuit & Waveform

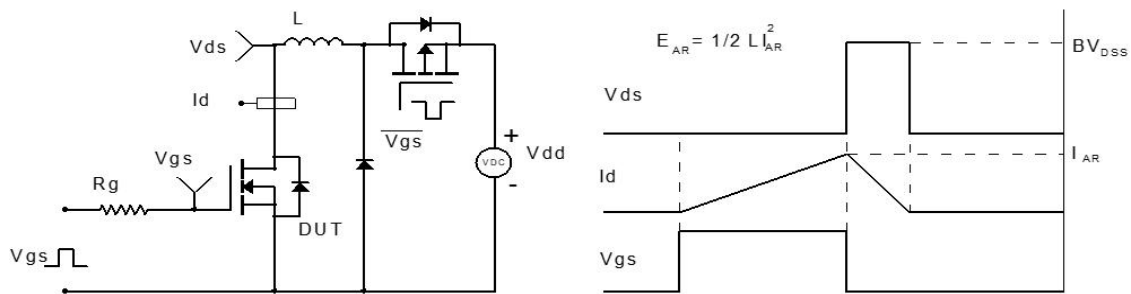


Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

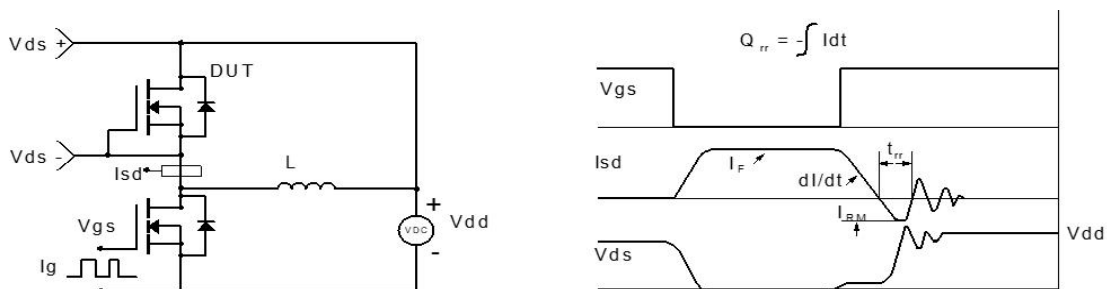
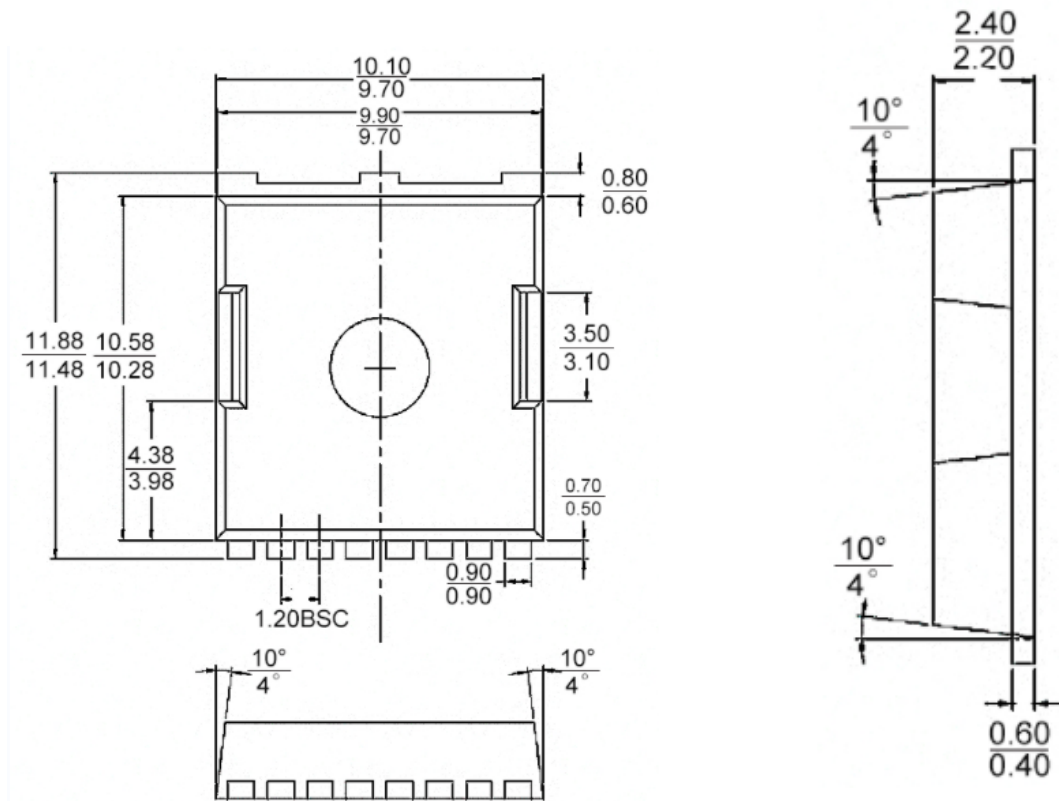
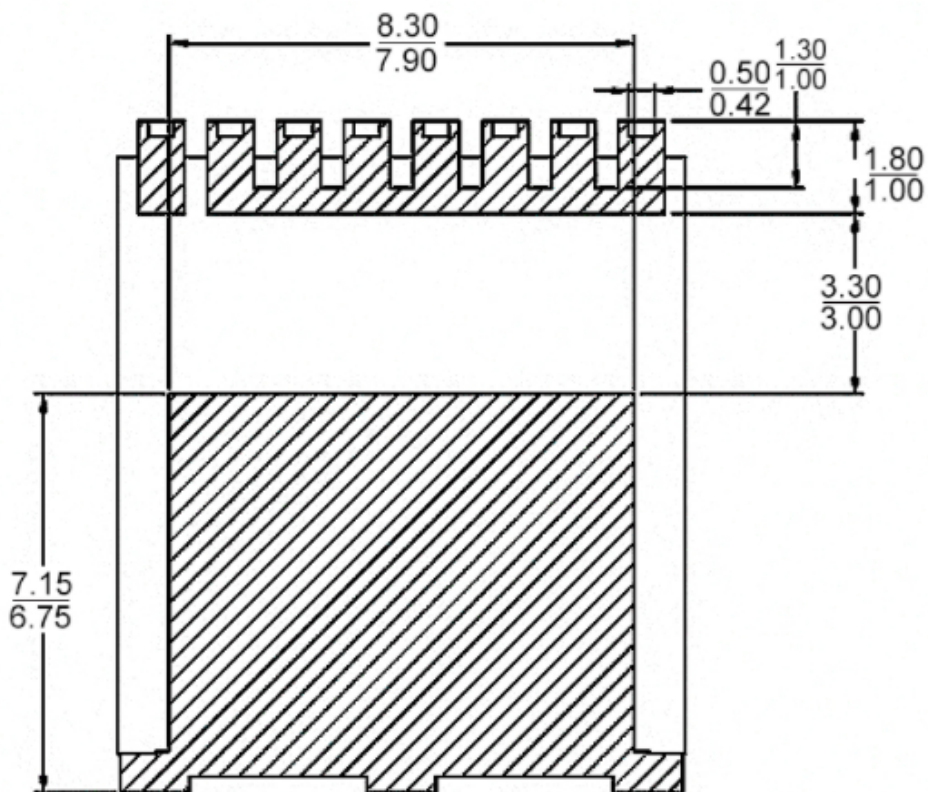


Figure 4: Diode Recovery Test Circuit & Waveform

TOLLA-8 Package Information

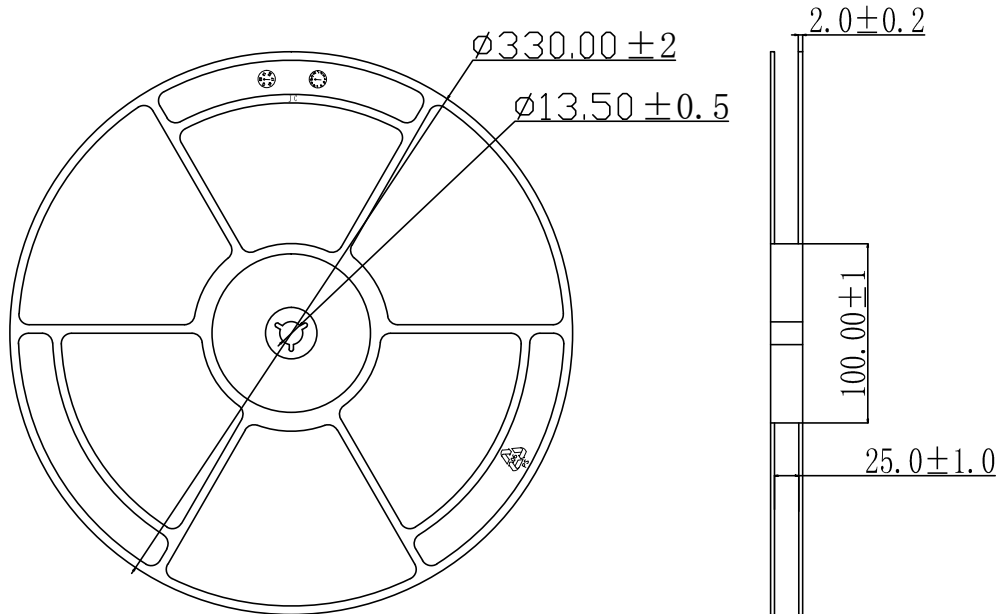


UNIT: mm

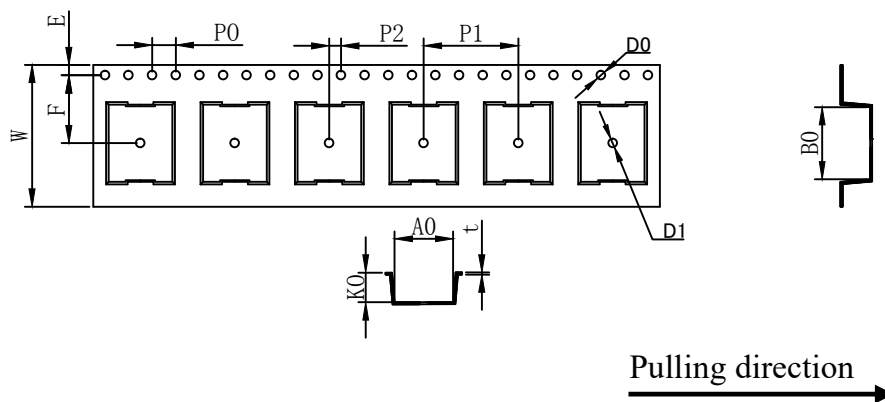


Tape & Reel Information

Dimensions in mm

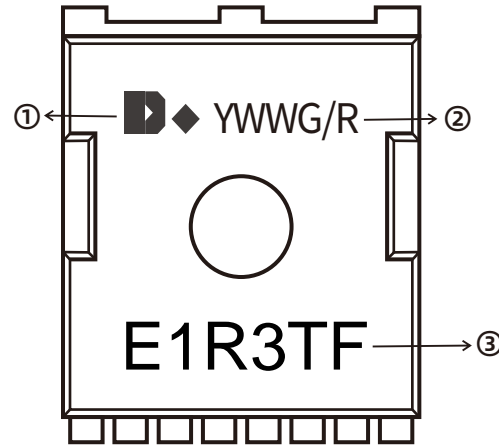


ITEM	A0	B0	D0	D1	E	F
TOLR	10.2 ± 0.1	12.05 ± 0.1	1.5 ± 0.1	1.5 ± 0.25	1.75 ± 0.1	11.5 ± 0.1
ITEM	W	t	K0	P0	P1	P2
TOLR	$24 \begin{smallmatrix} +0.3 \\ -0.15 \end{smallmatrix}$	0.30 ± 0.05	2.55 ± 0.1	4.0 ± 0.1	12.0 ± 0.1	2.0 ± 0.1



Package Information:


- ①. Doingter LOGO
- ②. Date Code(YWWG / R)
 Y : Year Code , last digit of the year
 WW : Week Code(01-53)
 G/R : G(Green) /R(Lead Free)
- ③. Part NO.



Previous Version

Version	Date	Subjects (major changes since last revision)
1.0	2025-08-10	Release of final version

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